Absolute Maximum Ratings

Rating	Symbol	Value	Units
Peak Pulse Power (tp = $8/20\mu s$)	P _{PK}	1200-1600	W
Peak Pulse Current (tp = $8/20\mu s$)	I _{PP}	8-80	A
ESD per IEC 61000-4-2 (Contact) ⁽¹⁾ ESD per IEC 61000-4-2 (Air) ⁽¹⁾	V _{ESD}	±30 ±30	kV
Operating Temperature	T,	-40 to +125	°C
Storage Temperature	T _{stg}	-55 to +150	°C

Electrical Characteristics (T=25°C unless otherwise specified)

μClamp0561P									
Parameter	Symbol	Conditions	Conditions		Тур.	Max.	Units		
Reverse Stand-Off Voltage	V _{RWM}	-40°C to 125°C, Pin	2 to Pin 1			5	V		
Reverse Breakdown Voltage	V _{BR}	$I_t = 1 \text{mA}$, Pin 2 to Pi	n 1	6	7	9	V		
Reverse Leakage Current	I _R	$V_{RWM} = 5V$	$V_{RWM} = 5V$ $T = 25^{\circ}C$		50	300	nA		
Peak Pulse Current	I _{PP}	tp = 8/20µs				80	А		
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 40A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			12	V		
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 80A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			15	V		
Dynamic Resistance ^{(3), (4)}	R _{DYN}	tp = 0.2/100ns (TLP), Pin 2 to Pin 1			0.05		Ohms		
Junction Capacitance	C	$V_{R} = 0V$, f = 1MHz Pin 2 to Pin 1	$T = 25^{\circ}C$			800	pF		

Notes:

(1): ESD Gun return path to Ground Reference Plane (GRP)

(2):Tested using a constant current source

(3): Transmission Line Pulse Test (TLP) Settings: tp = 100ns, tr = 0.2ns, I_{TLP} and V_{TLP} averaging window: $t_1 = 70$ ns to $t_2 = 90$ ns.

(4): Dynamic resistance calculated from $I_{_{TLP}}$ = 4A to $I_{_{TLP}}$ = 16A

μClamp1061P									
Parameter	Symbol	Conditions	Conditions			Max.	Units		
Reverse Stand-Off Voltage	V _{RWM}	-40°C to 125°C, Pin	2 to Pin 1			10	V		
Reverse Breakdown Voltage	V _{BR}	$I_t = 1mA$, Pin 2 to Pi	n 1	12	13.5	15.5	V		
Reverse Leakage Current	I _R	$V_{RWM} = 10V$	$V_{RWM} = 10V$ $T = 25^{\circ}C$		<10	100	nA		
Peak Pulse Current	I _{PP}	tp = 8/20µs				60	A		
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 10A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			17	V		
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 60A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			25	V		
Dynamic Resistance ^{(3), (4)}	R _{DYN}	tp = 0.2/100ns (TLP), Pin 2 to Pin 1			0.05		Ohms		
Junction Capacitance	C	$V_{R} = 0V, f = 1MHz$ Pin 2 to Pin 1	$T = 25^{\circ}C$			350	pF		

μClamp1261P								
Parameter	Symbol	Conditions		Min.	Тур.	Max.	Units	
Reverse Stand-Off Voltage	V _{RWM}	-40°C to 125°C, Pin	2 to Pin 1			12	V	
Reverse Breakdown Voltage	V _{BR}	$I_t = 1 \text{mA}$, Pin 2 to Pi	n 1	14	16.5	19	V	
Reverse Leakage Current	I _R	$V_{RWM} = 12V$	$V_{RWM} = 12V$ $T = 25^{\circ}C$		<10	100	nA	
Peak Pulse Current	I _{PP}	tp = 8/20µs				45	A	
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 10A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			25	V	
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 45A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			33	V	
Dynamic Resistance ^{(3), (4)}	R _{DYN}	tp = 0.2/100ns (TLP), Pin 2 to Pin 1			0.05		Ohms	
Junction Capacitance	C	$V_{R} = 0V, f = 1MHz$ Pin 2 to Pin 1	$T = 25^{\circ}C$			275	pF	

μClamp1561P									
Parameter	Symbol	Conditions	Conditions			Max.	Units		
Reverse Stand-Off Voltage	V _{RWM}	-40°C to 125°C, Pin	2 to Pin 1			15	V		
Reverse Breakdown Voltage	V _{BR}	I _t =1mA, Pin 2 to Pi	n 1	17.5	20	23	V		
Reverse Leakage Current	I _R	$V_{RWM} = 15V$	$V_{RWM} = 15V$ $T = 25^{\circ}C$		<10	100	nA		
Peak Pulse Current	I _{PP}	tp = 8/20µs				40	A		
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 10A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			28	V		
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 40A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			40	V		
Dynamic Resistance ^{(3), (4)}	R _{DYN}	tp = 0.2/100ns (TLP), Pin 2 to Pin 1			0.05		Ohms		
Junction Capacitance	C	$V_{R} = 0V, f = 1MHz$ Pin 2 to Pin 1	$T = 25^{\circ}C$			220	pF		

μClamp2461P								
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units		
Reverse Stand-Off Voltage	V _{RWM}	-40°C to 125°C, Pin	2 to Pin 1			24	V	
Reverse Breakdown Voltage	V _{BR}	$I_t = 1 \text{mA}$, Pin 2 to Pi	n 1	27	32	36	V	
Reverse Leakage Current	l _R	$V_{RWM} = 24V$ $T = 25^{\circ}C$			<10	100	nA	
Peak Pulse Current	I _{PP}	tp = 8/20µs				23	A	
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 10A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			50	V	
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 23A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			65	V	
Dynamic Resistance ^{(3), (4)}	R _{DYN}	tp = 0.2/100ns (TLP), Pin 2 to Pin 1			0.20		Ohms	
Junction Capacitance	C,	$V_{R} = 0V, f = 1MHz$ Pin 2 to Pin 1	T = 25°C			165	pF	

μClamp3061P									
Parameter	Symbol	Conditions	Conditions			Max.	Units		
Reverse Stand-Off Voltage	V _{RWM}	-40°C to 125°C, Pin	2 to Pin 1			30	V		
Reverse Breakdown Voltage	V _{BR}	$I_t = 1mA$, Pin 2 to Pi	n 1	34	40	42	V		
Reverse Leakage Current	I _R	$V_{RWM} = 30V$	$V_{RWM} = 30V$ $T = 25^{\circ}C$		<10	100	nA		
Peak Pulse Current	I _{PP}	tp = 8/20µs				18	A		
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 10A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			55	V		
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 18A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			65	V		
Dynamic Resistance ^{(3), (4)}	R _{DYN}	tp = 0.2/100ns (TLP), Pin 2 to Pin 1			0.25		Ohms		
Junction Capacitance	C	$V_{R} = 0V, f = 1MHz$ Pin 2 to Pin 1	$T = 25^{\circ}C$			155	pF		

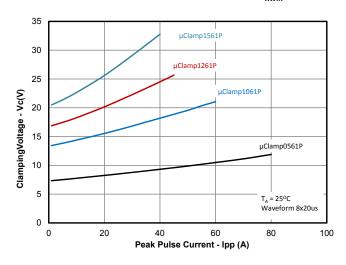
μClamp3661P								
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units		
Reverse Stand-Off Voltage	V _{RWM}	-40°C to 125°C, Pin	2 to Pin 1			36	V	
Reverse Breakdown Voltage	V _{BR}	$I_t = 1$ mA, Pin 2 to Pir	ו 1	37	40	44	V	
Reverse Leakage Current	l _R	$V_{RWM} = 36V$ $T = 25^{\circ}C$			<10	100	nA	
Peak Pulse Current	I _{PP}	tp = 8/20µs				18	A	
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 2A, tp = 8/20\mu s$, Pin 2 to Pin 1			48	V	
Clamping Voltage ⁽²⁾	V _c	I _{PP} = 18A, tp = 8/20µ	ıs, Pin 2 to Pin 1			70	V	
Dynamic Resistance ^{(3), (4)}	R _{DYN}	tp = 0.2/100ns (TLP), Pin 2 to Pin 1			0.25		Ohms	
Junction Capacitance	C	$V_{R} = 0V$, f = 1MHz Pin 2 to Pin 1	T = 25°C			150	pF	

μClamp4061P									
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units			
Reverse Stand-Off Voltage	V _{RWM}	-40°C to 125°C, Pin	2 to Pin 1			40	V		
Reverse Breakdown Voltage	V _{BR}	$I_t = 1$ mA, Pin 2 to Pir	l _t = 1mA, Pin 2 to Pin 1		50	55	V		
Reverse Leakage Current	I _R	$V_{RWM} = 40V$	T = 25°C		<10	100	nA		
Peak Pulse Current	I _{PP}	tp = 8/20µs				12	А		
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 12A, tp = 8/20\mu$	ıs, Pin 2 to Pin 1			80	V		
Dynamic Resistance ^{(3), (4)}	R _{DYN}	tp = 0.2/100ns (TLP), Pin 2 to Pin 1			0.35		Ohms		
Junction Capacitance	C	$V_{R} = 0V, f = 1MHz$ Pin 2 to Pin 1	$T = 25^{\circ}C$			125	pF		

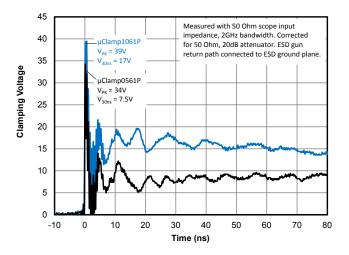
μClamp6061P								
Parameter	Symbol	Conditions		Min.	Тур.	Max.	Units	
Reverse Stand-Off Voltage	V _{RWM}	-40°C to 125°C, Pin	2 to Pin 1			60	V	
Reverse Breakdown Voltage	V _{BR}	$I_t = 1$ mA, Pin 2 to Pir	65	70	85	V		
Reverse Leakage Current	I _R	$V_{RWM} = 60V$	$V_{RWM} = 60V$ $T = 25^{\circ}C$		<10	100	nA	
Peak Pulse Current	I _{PP}	tp = 8/20µs				8	A	
Clamping Voltage ⁽²⁾	V _c	$I_{pp} = 8A, tp = 8/20\mu s$, Pin 2 to Pin 1			105	V	
Dynamic Resistance ^{(3), (4)}	R _{DYN}	tp = 0.2/100ns (TLP) Pin 2 to Pin 1			0.45		Ohms	
Junction Capacitance	C	$V_{R} = 0V, f = 1MHz$ Pin 2 to Pin 1	T = 25°C			110	pF	

Typical Characteristics

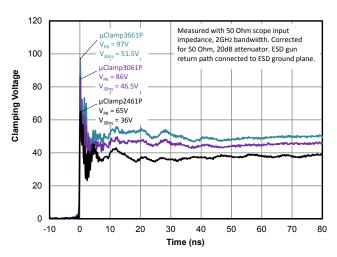
Clamping Voltage vs. Peak Pulse Current (V_{RWM} = 5V - 15V)



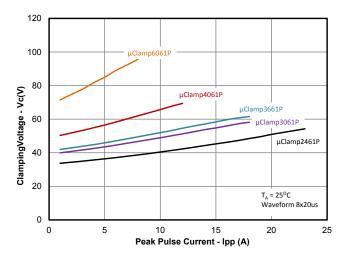
ESD Clamping (8kV Contact per IEC 61000-4-2)



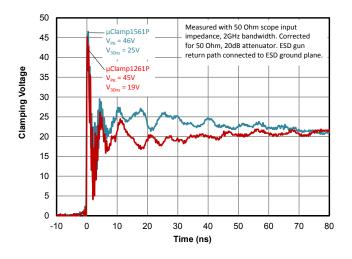
ESD Clamping (8kV Contact per IEC 61000-4-2)



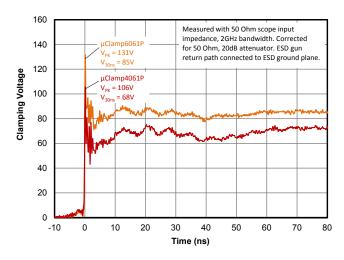
μClamp0561P - μClamp6061P Final Datasheet Rev 4.2 Revision date 1/24/2018 Clamping Voltage vs. Peak Pulse Current ($V_{RWM} = 24V - 60V$)



ESD Clamping (8kV Contact per IEC 61000-4-2)



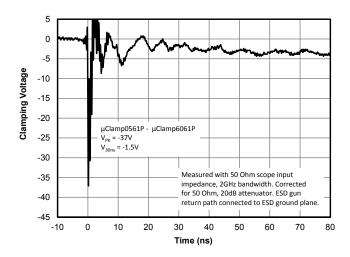




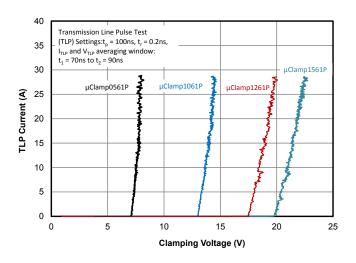
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Typical Characteristics

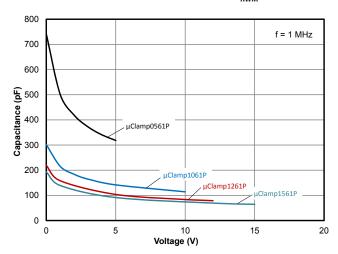
ESD Clamping (-8kV Contact per IEC 61000-4-2)



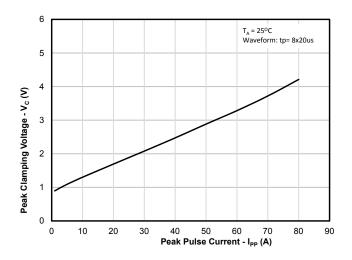
TLP Characteristic (Positive Pulse) - ($V_{RWM} = 5V - 15V$)



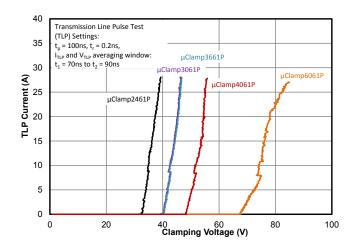
Capacitance vs. Reverse Voltage - ($V_{RWM} = 5V - 15V$)



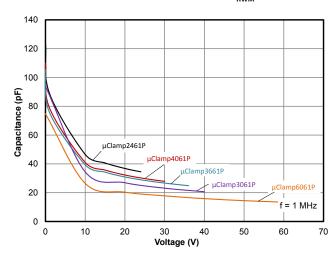
μClamp0561P - μClamp6061P Final Datasheet Rev 4.2 Revision date 1/24/2018 Forward Voltage vs. Peak Pulse Current ($V_{RWM} = 5V - 60V$)



TLP Characteristic (Positive Pulse) - ($V_{RWM} = 24V - 60V$)



Capacitance vs. Reverse Voltage - (V_{RWM} = 24V - 60V)



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Application Information

Assembly Guidelines

The figure at the right details Semtech's recommended mounting pattern. Recommended assembly guidelines are shown in Table 1. Note that these are only recommendations and should serve only as a starting point for design since there are many factors that affect the assembly process. Exact manufacturing parameters will require some experimentation to get the desired solder application. Semtech's recommended mounting pattern is based on the following design guidelines:

Land Pattern

The recommended land pattern follows IPC standards and is designed for maximum solder coverage. Detailed dimensions are shown elsewhere in this document.

Solder Stencil

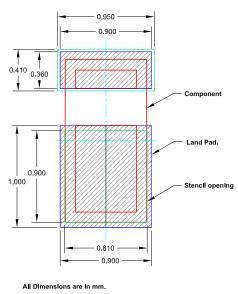
Stencil design is one of the key factors which will determine the volume of solder paste deposited onto the land pad. The area ratio of the stencil aperture will determine how well the stencil will print. The area ratio takes into account the aperture shape, aperture size, and stencil thickness. An area ratio of 0.70 – 0.75 is preferred for the subject package. The area ratio of a rectangular aperture is given as:

Area Ratio = (L * W) / (2 * (L + W) * T)

Where: L = Aperture Length W = Aperture Width T = Stencil Thickness

Semtech recommends a stencil thickness of 0.125mm for this device. The stencil should be laser cut with electropolished finish. The stencil should have a positive taper of approximately 5 degrees. Electro polishing and tapering the walls results in reduced surface friction and better paste release. Since this device has uneven pad sizes, the recommended stencil opening is 10% smaller than the size of the large pad and 25um larger than the size of the small pad. This is done to control solder height and keep the part planar during reflow. Solder paste with Type 3 or smaller particles are recommended.

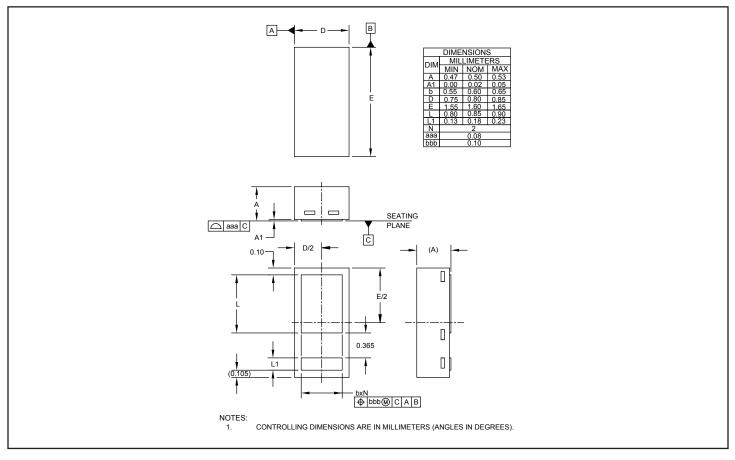
Recommended Mounting Pattern



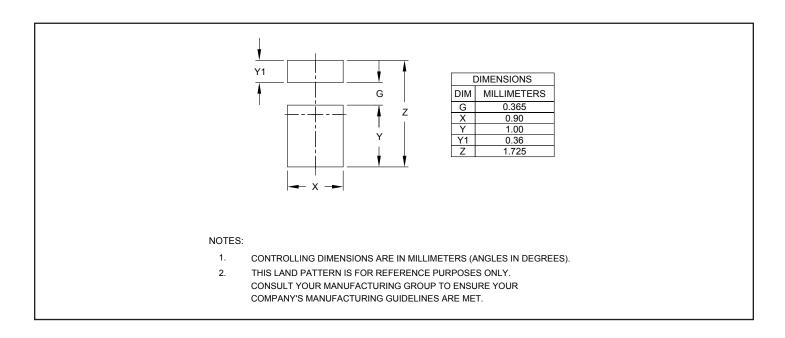
ZZZ Land Pad. Stencil opening Component

Table 1 - Recommended Assembly Guidelines								
Assembly Parameter	Recommendation							
Solder Stencil Design	Laser Cut, Electro-Polished							
Aperture Shape	Rectangular							
Solder Stencil Thickness	0.125mm (0.005″)							
Solder Paste Type	Type 3 size sphere or smaller							
Solder Reflow Profile	Per JEDEC J-STD-020							
PCB Solder pad Design	Non-Solder Mask Defined							
PCB Pad Finish	OSP or NiAu							

Outline Drawing - SLP1608P2

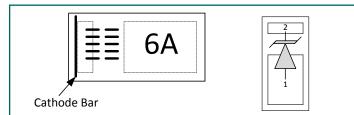


Land Pattern - SLP1608P2



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Marking



Notes:

1) Dashes represent matrix date code

2) See ordering information for part specific marking codes

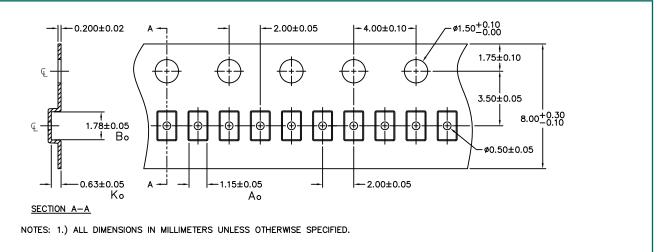
Ordering Information

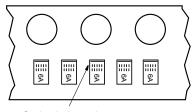
Part Number	Marking Code	Working Voltage	Qty per 7" Reel
µClamp0561P.TNT	6A	5V	10,000
µClamp1061P.TNT	6B	10V	10,000
µClamp1261P.TNT	6C	12V	10,000
µClamp1561P.TNT	6D	15V	10,000
µClamp2461P.TNT	6F	24V	10,000
µClamp3061P.TNT	6G	30V	10,000
µClamp3661P.TNT	6H	36V	10,000
µClamp4061P.TNT	6J	40V	10,000
µClamp6061P.TNT	6K	60V	10,000

Notes:

1) MicroClamp, uClamp and μ Clamp are trademarks of Semtech Corporaton

Tape and Reel Specification





Cathode Location (Towards Sprocket Holes)



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